# 54F322,74F322

54F322 Octal Serial/Parallel Register with Sign Extend



Literature Number: SNOS187A

## 54F/74F322 Octal Serial/Parallel Register with Sign Extend

## **General Description**

The 'F322 is an 8-bit shift register with provision for either serial or parallel loading and with TRI-STATE® parallel outputs plus a bi-state serial output. Parallel data inputs and parallel outputs are multiplexed to minimize pin count. State changes are initiated by the rising edge of the clock. Four synchronous modes of operation are possible: hold (store), shift right with serial entry, shift right with sign extend and parallel load. An asynchronous Master Reset (MR) input overrides clocked operation and clears the register.

#### **Features**

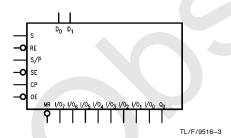
- Multiplexed parallel I/O ports
- Separate serial input and output
- Sign extend function
- TRI-STATE outputs for bus applications

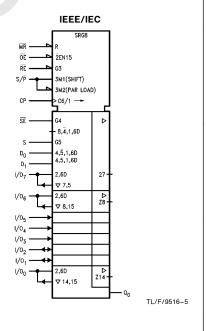
Commercial	Military	Package Number	Package Description
74F322PC		N20A	20-Lead (0.300" Wide) Molded Dual-In-Line
	54F322DM (Note 2)	J20A	20-Lead Ceramic Dual-In-Line
74F322SJ (Note 1)		M20D	20-Lead (0.300" Wide) Molded Small Outline, EIAJ
	54F322FM (Note 2)	W20A	20-Lead Cerpack
	54F322LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C

Note 1: Devices also available in 13" reel. Use suffix = SJX.

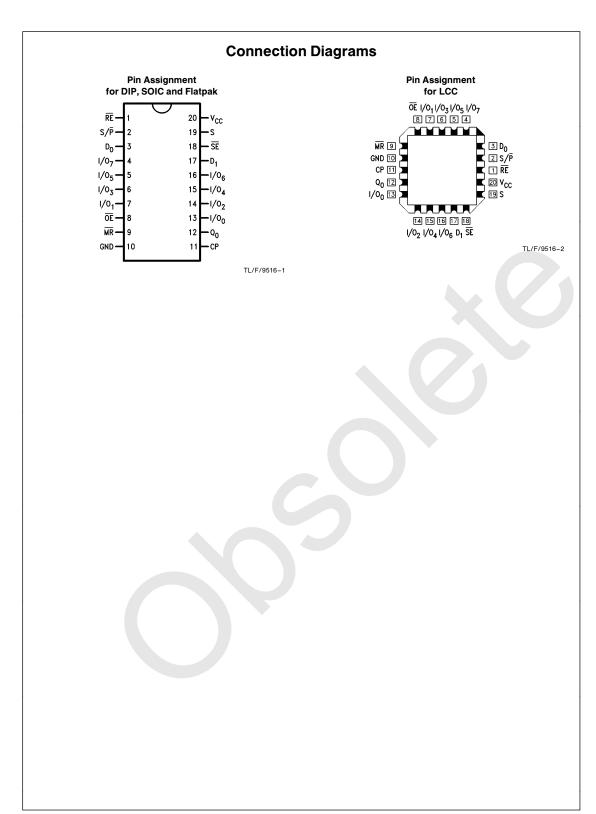
Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

## **Logic Symbols**





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### **Unit Loading/Fan Out**

		54F/74F				
Pin Names	Description	U.L. HIGH/LOW	Input I <sub>IH</sub> /I <sub>IL</sub> Output I <sub>OH</sub> /I <sub>OL</sub>			
RE	Register Enable Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA			
S/P	Serial (HIGH) or Parallel (LOW) Mode Control Input	1.0/1.0	20 μA/-0.6 mA			
SE	Sign Extend Input (Active LOW)	1.0/3.0	20 μA/ – 1.8 mA			
S	Serial Data Select Input	1.0/2.0	20 μA/ – 1.2 mA			
D <sub>0</sub> , D <sub>1</sub>	Serial Data Inputs	1.0/1.0	20 μA/ – 0.6 mA			
CP	Clock Pulse Input (Active Rising Edge)	1.0/1.0	20 μA/ – 0.6 mA			
MR	Asynchronous Master Reset Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA			
ŌĒ	TRI-STATE Output Enable Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA			
$Q_0$	Bi-State Serial Output	50/33.3	-1 mA/-20 mA			
1/00-1/07	Multiplexed Parallel Data Inputs or	3.5/1.083	70 μA/ – 0.65 mA			
	TRI-STATE Parallel Data Outputs	150/40 (33.3)	-3 mA/24 mA (20 mA)			

### **Functional Description**

The 'F322 contains eight D-type edge triggered flip-flops and the interstage gating required to perform right shift and the intrastage gating necessary for hold and synchronous parallel load operations. A LOW signal on RE enables shifting or parallel loading, while a HIGH signal enables the hold mode. A HIGH signal on S/P enables shift right, while a LOW signal disables the TRI-STATE output buffers and enables parallel loading. In the shift right mode a HIGH signal on  $\overline{SE}$  enables serial entry from either D<sub>0</sub> or D<sub>1</sub>, as determined by the S input. A LOW signal on SE enables shift right but Q7 reloads its contents, thus performing the sign extend function required for the 'F384 Twos Complement Multiplier. A HIGH signal on  $\overline{\text{OE}}$  disables the TRI-STATE output buffers, regardless of the other control inputs. In this condition the shifting and loading operations can still be performed.

#### Mode Select Table

Mode Inputs					Outputs								Q <sub>0</sub>			
	MR	RE	S/P	SE	s	ŌE*	СР	1/07	1/06	1/05	1/04	1/03	1/02	I/O <sub>1</sub>	I/O <sub>0</sub>	α0
Clear	L L	X X	X X	X X	X X	L H	X X	L Z	L L							
Parallel Load	Н	L	L	Х	Х	х	5	I <sub>7</sub>	I <sub>6</sub>	l <sub>5</sub>	l <sub>4</sub>	l <sub>3</sub>	l <sub>2</sub>	I <sub>1</sub>	I <sub>0</sub>	I <sub>O</sub>
Shift Right	H H	L L	H H	H H	L H	L L	\ \ \	D <sub>0</sub> D <sub>1</sub>	O <sub>7</sub> O <sub>7</sub>	O <sub>6</sub> O <sub>6</sub>	O <sub>5</sub> O <sub>5</sub>	O <sub>4</sub> O <sub>4</sub>	O <sub>3</sub> O <sub>3</sub>	O <sub>2</sub> O <sub>2</sub>	O <sub>1</sub> O <sub>1</sub>	O <sub>1</sub>
Sign Extend	Н	L	н	L	x	L	~	07	07	O <sub>6</sub>	O <sub>5</sub>	04	О3	02	01	01
Hold	Н	Н	Χ	Х	Х	L		NC	NC							

\*When the  $\overline{\text{OE}}$  input is HIGH all I/O<sub>n</sub> terminals are at the high impedance state; sequential operation or clearing of the register is not affected.

Note 1: 17-10 = The level of the steady-state input at the respective I/O terminal is loaded into the flip-flop while the flip-flop outputs (except Q<sub>0</sub>) are isolated from

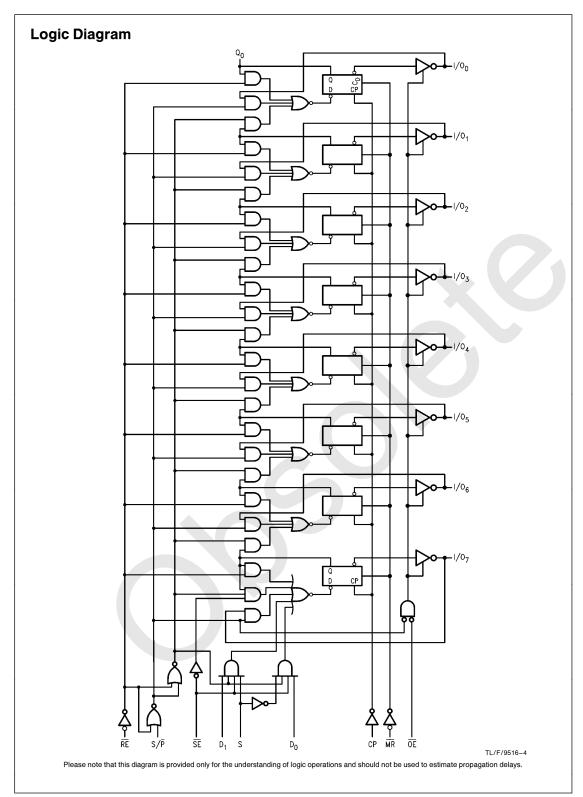
**Note 2:**  $D_0$ ,  $D_1$  = The level of the steady-state inputs to the serial multiplexer input.

Note 3:  $O_7$ – $O_0$  = The level of the respective  $O_n$  flip-flop prior to the last Clock LOW-to-HIGH transition. H = HIGH Voltage Level

L = LOW Voltage Level Z = High Impedance Output State

= LOW-to-HIGH Transition

NC = No Change



### **Absolute Maximum Ratings** (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature -65°C to +150°C Ambient Temperature under Bias -55°C to +125°C Junction Temperature under Bias -55°C to +175°C Plastic -55°C to +150°C

V<sub>CC</sub> Pin Potential to

Ground Pin -0.5V to +7.0VInput Voltage (Note 2) -0.5V to +7.0VInput Current (Note 2) -30~mA to +5.0~mA

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

- 0.5V to V $_{\rm CC}$  - 0.5V to + 5.5V Standard Output TRI-STATE Output

Current Applied to Output

twice the rated  $I_{OL}$  (mA) in LOW State (Max)

### **Recommended Operating Conditions**

Free Air Ambient Temperature

Military -55°C to +125°C 0°C to +70°C Commercial

Supply Voltage

Military  $+\,4.5V$  to  $+\,5.5V$ Commercial +4.5V to +5.5V

### **DC Electrical Characteristics**

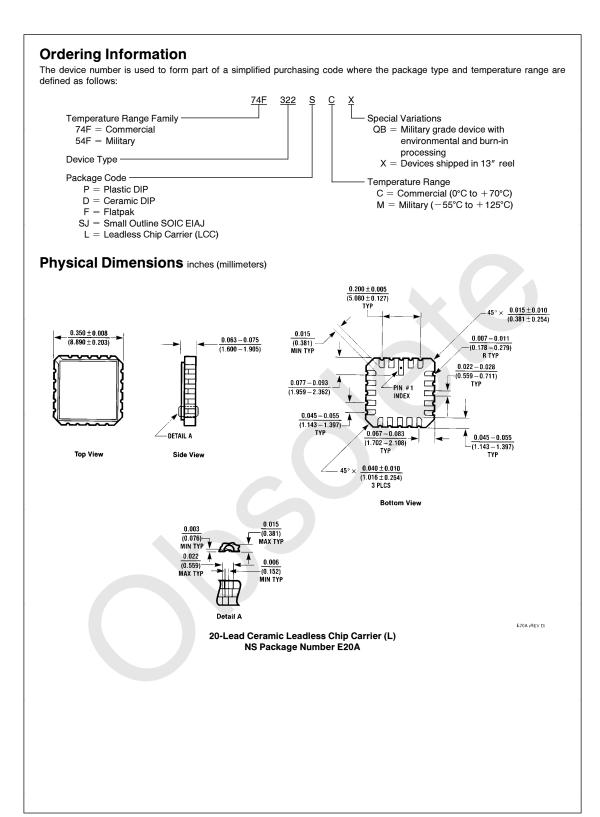
Symbol	Parameter			54F/74	F	Units	v <sub>cc</sub>	Conditions		
Symbol	raiamete	<b>71</b>	Min	Тур	Max	Onits	VCC	Containons		
V <sub>IH</sub>	Input HIGH Voltage		2.0			٧		Recognized as a HIGH Signal		
V <sub>IL</sub>	Input LOW Voltage				0.8	٧		Recognized as a LOW Signal		
V <sub>CD</sub>	Input Clamp Diode Volta	age			-1.2	٧	Min	$I_{IN} = -18 \text{ mA}$		
V <sub>OH</sub>	Output HIGH Voltage	54F 10% V <sub>CC</sub> 54F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub> 74F 5% V <sub>CC</sub> 74F 5% V <sub>CC</sub>	2.5 2.4 2.5 2.4 2.7 2.7			>	Min	$\begin{split} I_{OH} &= -1 \text{ mA } (Q_0, I/O_n) \\ I_{OH} &= -3 \text{ mA } (I/O_n) \\ I_{OH} &= -1 \text{ mA } (Q_0, I/O_n) \\ I_{OH} &= -3 \text{ mA } (I/O_n) \\ I_{OH} &= -1 \text{ mA } (Q_0, I/O_n) \\ I_{OH} &= -3 \text{ mA } (I/O_n) \end{split}$		
V <sub>OL</sub>	Output LOW Voltage	54F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub>			0.5 0.5 0.5	٧	Min	$\begin{split} I_{OL} &= 20 \text{ mA } (Q_0, I/O_n) \\ I_{OL} &= 20 \text{ mA } (Q_0) \\ I_{OL} &= 24 \text{ mA } (I/O_n) \end{split}$		
I <sub>IH</sub>	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	$V_{IN} = 2.7V$		
I <sub>BVI</sub>	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	V <sub>IN</sub> = 7.0V (Non-I/O Inputs)		
I <sub>BVIT</sub>	Input HIGH Current Breakdown Test (I/O)	54F 74F	X		1.0 0.5	mA	Max	$V_{IN} = 5.5V (I/O_n)$		
I <sub>CEX</sub>	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	$V_{OUT} = V_{CC}$		
$V_{\text{ID}}$	Input Leakage Test	74F	4.75			٧	0.0	I <sub>ID</sub> = 1.9 μA All Other Pins Grounded		
I <sub>OD</sub>	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V <sub>IOD</sub> = 150 mV All Other Pins Grounded		
I <sub>IL</sub>	Input LOW Current				-0.6 -1.2 -1.8	mA mA mA	Max Max Max	$ \begin{array}{l} \textbf{V}_{\text{IN}} = 0.5 \textbf{V} \left( \overline{\text{RE}}, \textbf{S}/\overline{\textbf{P}}, \textbf{D}_{\text{n}}, \textbf{CP}, \overline{\textbf{MR}}, \overline{\textbf{OE}} \right) \\ \textbf{V}_{\text{IN}} = 0.5 \textbf{V} \left( \overline{\textbf{S}} \right) \\ \textbf{V}_{\text{IN}} = 0.5 \textbf{V} \left( \overline{\textbf{SE}} \right) \end{array} $		
I <sub>IH</sub> + I <sub>OZH</sub>	Output Leakage Current	t			70	μΑ	Max	$V_{I/O} = 2.7V (I/O_n)$		
I <sub>IL</sub> + I <sub>OZL</sub>	Output Leakage Current	t			-650	μΑ	Max	$V_{I/O} = 0.5V (I/O_n)$		
los	Output Short-Circuit Cur	rrent	-60		-150	mA	Max	V <sub>OUT</sub> = 0V		
$I_{ZZ}$	Bus Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V		
Icc	Power Supply Current			60	90	mA	Max			

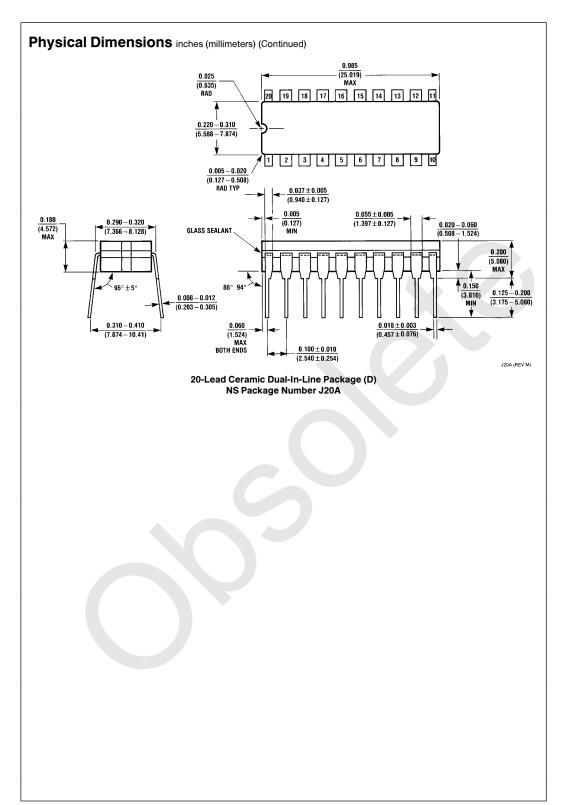
## **AC Electrical Characteristics**

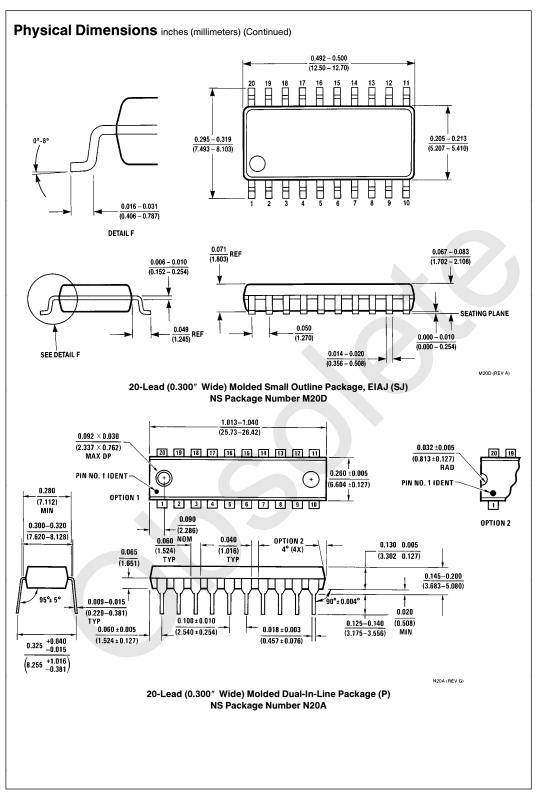
			74F		5	4F	7	Units	
Symbol	Parameter	V	$egin{aligned} \Gamma_{ extsf{A}} &=  + 25^{\circ} \ \gamma_{ extsf{CC}} &=  + 5.0 \ C_{ extsf{L}} &=  50 \  ext{pF} \end{aligned}$	V		<sub>C</sub> = Mil 50 pF	T <sub>A</sub> , V <sub>CC</sub> C <sub>L</sub> =		
		Min	Тур	Max	Min	Max	Min	Max	
f <sub>max</sub>	Maximum Clock Frequency	70	90		50		70		MHz
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay CP to I/O <sub>n</sub>	3.5 5.0	7.0 8.5	7.5 11.0	3.5 3.5	9.5 10.0	3.5 5.0	8.5 12.0	ns
t <sub>PLH</sub>	Propagation Delay CP to Q <sub>0</sub>	3.5 3.5	7.0 7.0	9.0 8.0	3.5 3.5	11.0 10.0	3.5 3.5	10.0 9.0	113
t <sub>PHL</sub>	Propagation Delay MR to I/On	6.0	10.0	13.0	6.0	15.0	6.0	14.0	ns
t <sub>PHL</sub>	Propagation Delay MR to Q <sub>0</sub>	5.5	7.5	12.0	5.5	14.0	5.5	13.0	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output Enable Time  OE to I/On	3.0 4.0	6.5 8.5	9.0 11.0	3.0 4.0	12.5 14.5	3.0 4.0	10.0 12.0	ns
t <sub>PHZ</sub>	Output Disable Time  OE to I/On	2.0 2.0	4.5 5.0	6.0 7.0	2.0 2.0	8.0 10.0	2.0 2.0	7.0 8.0	
t <sub>PZH</sub>	Output Enable Time S/P to I/On	4.5 5.5	8.0 10.0	10.5 14.0	4.5 5.5	13.5 17.0	4.5 5.5	11.5 15.0	ns
t <sub>PHZ</sub>	Output Disable Time S/P to I/On	5.0 6.0	9.0 12.0	11.5 15.5	5.0 6.0	16.5 19.5	5.0 6.0	12.5 16.5	113

## **AC Operating Requirements**

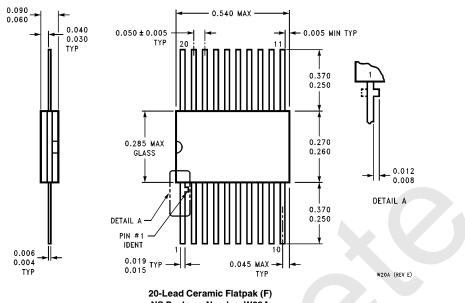
		74	F	54	F	7	4F	
Symbol	Parameter	T <sub>A</sub> = +		T <sub>A</sub> , V <sub>CC</sub>	= Mil	$T_A$ , $V_{CC} = Com$		Units
		Min	Max	Min	Max	Min	Max	
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup Time, HIGH or LOW RE to CP	6.0 14.0		14.0 18.0		7.0 16.0		ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold Time, HIGH or LOW RE to CP	0 0		0 0		0		ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup Time, HIGH or LOW D <sub>0</sub> , D <sub>1</sub> or I/O <sub>n</sub> to CP	6.5 6.5		8.5 8.5		7.5 7.5		ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold Time, HIGH or LOW D <sub>0</sub> , D <sub>1</sub> or I/O <sub>n</sub> to CP	2.0 2.0		3.0 3.0		3.0 3.0		ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup Time, HIGH or LOW SE to CP	7.0 2.5		9.0 11.0		8.0 3.5		ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold Time, HIGH or LOW SE to CP	2.0 0.0		2.0 1.0		2.0 0.0		ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup Time, HIGH or LOW S/P to CP	11.0 13.5		13.0 21.0		12.0 15.5		ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup Time, HIGH or LOW S to CP	6.5 9.0		8.5 11.0		7.5 10.0		ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold Time, HIGH or LOW S or S/P to CP	0 0		1.0 0		0		ns
t <sub>w</sub> (H) t <sub>w</sub> (L)	CP Pulse Width, HIGH or LOW	7.0		8.0		7.0		ns
t <sub>w</sub> (L)	MR Pulse Width, LOW	5.5		7.5		6.5		
t <sub>rec</sub>	Recovery Time MR to CP	8.0		12.0		8.0		ns







## Physical Dimensions inches (millimeters) (Continued)



## NS Package Number W20A

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